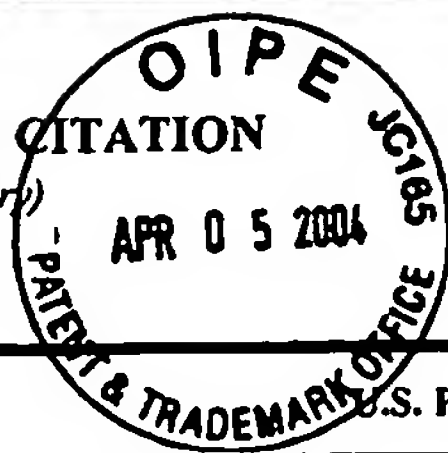


INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)



Docket Number (Optional)
BUR920030164US1

Application Number
10/708,820

Applicant(s)
William F. DeCamp et al.

Filing Date
3/26/04

Group Art Unit
2825

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
							YES	NO
PD		JP2003067441A	03/07/2003	Japan				

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER Paul Dinh / Paul Dinh/

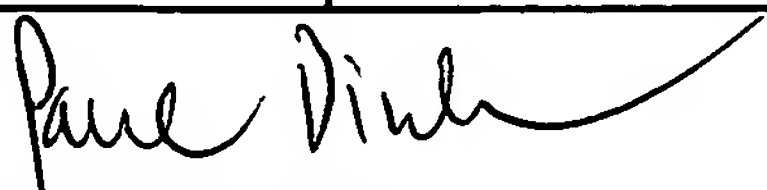
DATE CONSIDERED 05/09/2006

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

IDS - 03/26/2004 **ELECTRONIC INFORMATION DISCLOSURE STATEMENT**

Electronic Version v18

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Title of Invention	IC DESIGN DENSITY CHECKING METHOD, SYSTEM AND PROGRAM PRODUCT						
<p>Application Number : 10/708,820</p> <p>Confirmation Number:</p> <p>First Named Applicant: William DeCamp</p> <p>Attorney Docket Number: BUR920030164US1</p> <p>Art Unit: 2825</p> <p>Examiner: Paul Dinh</p> <p>Search string: (6493658 or 6189130 or 6134702 or 20020066064).pn</p>							
US Patent Documents							
Note: Applicant is not required to submit a paper copy of cited US Patent Documents							
init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass
PD	1	6493658	2002-12-10	Koford et al.			
PD	2	6189130	2002-05-30	Gofman et al.			
PD	3	6134702	2000-10-17	Scepanovic et al.			
US Published Applications							
Note: Applicant is not required to submit a paper copy of cited US Published Applications							
init	Cite.No.	Pub. No.	Date	Applicant	Kind	Class	Subclass
PD	1	20020066064	2002-05-03	Kamath et al.			
Signature 							
Examiner Name				Date			
/Paul Dinh/				05/09/2006			